

# CH-410 Physical and chemical analyses of materials

	Roussel Christophe	
Cursus	Sem.	Type
Chimiste	MA1, MA3	Opt.
Ingchim.	MA1, MA3	Opt.

Language of **English** teaching Credits Session Winter Semester Fall Exam Written Workload 90h Weeks 14 2 weekly Hours 2 weekly Courses Number of positions

# **Summary**

The course relates on the use of electromagnetic (X-Ray) and corpuscular (electrons) radiations for physical and chemical analysis of solid materials.

### Content

### 1. Fundamentals of beam interactions with materials

- Matter excitation: elastic, inelastic interactions of X-ray photons and electrons with matter
- Matter relaxation: spectroscopy and spectrometry

## 2. Microscopy

- Electron microscopy: Scanning and Transmission Electron Microscopies
- Scanning probe microscopy: Scanning Tunelling and Atomic Force Microscopies

# 3. Chemical analysis

- Bulk analysis of materials: X-ray emission and X-ray Fluorescence Spectrometries
- Surface analysis of materials: X-Ray Photoelectron and Auger Electron Spectrometries

# 4. Chemiometry

- · Basics of statistics
- Analyses of variance ANOVA

## **Assessment methods**

Final written exam